

Final datasheet XHP™2 module with CoolSiC™ Trench MOSFET

Features

- · Electrical features
 - V_{DSS} = 3300 V
 - $I_{DN} = 750 \text{ A} / I_{DRM} = 1500 \text{ A}$
 - $T_{vj,op} = 175$ °C
 - Low switching losses
 - High current density
 - Low inductive design
- Mechanical features
 - High power density
 - Package with CTI > 600
 - High creepage and clearance distances
 - AlSiC base plate for increased thermal cycling capability
 - AlN substrate with low thermal resistance

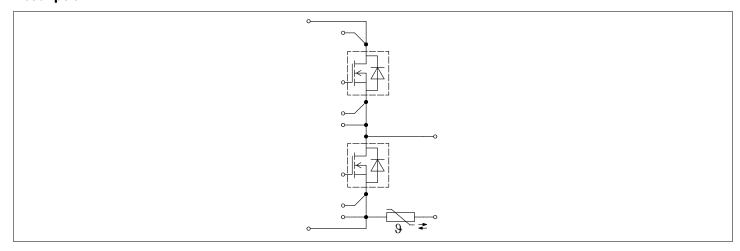
Potential applications

- Traction drives
- High-power converters
- High-frequency switching application

Product validation

• Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

Description





XHP™2 module

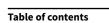




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XHP™2 module

1 Package



1 Package

Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V _{ISOL}	RMS, f = 50 Hz, t = 1 min	6.0	kV
Partial discharge extinction voltage	$V_{\rm isol}$	RMS, $f = 50 \text{ Hz}, Q_{PD} \le 10 \text{ pC}$	2.6	kV
DC stability	V _{CE(D)}	T _{vj} = 25 °C, 100 Fit	2100	V
Material of module baseplate			AlSiC	
Creepage distance	$d_{Creep\ nom}$	terminal to baseplate, nom.	40.0	mm
Creepage distance	$d_{\text{Creep nom}}$	terminal to terminal, nom.	34.0	mm
Clearance	d _{Clear nom}	terminal to baseplate, nom.	31.0	mm
Clearance	d _{Clear nom}	terminal to terminal, nom.	8.0	mm
Comparative tracking index	CTI		> 600	

Table 2 Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Stray inductance module	L _{sCE}				10		nH
Module lead resistance, terminals - chip	R _{CC'+EE'}	$T_C = 25$ °C, per switch			0.43		mΩ
Storage temperature	$T_{\rm stg}$			-40		150	°C
Maximum baseplate operation temperature	T_{BPmax}					150	°C
Mounting torque for module mounting	М	- Mounting according to valid application note	M6, Screw	4.25		5.75	Nm
Terminal connection	М	- Mounting according to	M3, Screw	0.9		1.1	Nm
torque		valid application note	M8, Screw	8		10	
Weight	G				720		g

2 MOSFET

Table 3 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	V_{DSS}		T _{vj} = 25 °C	3300	V
Implemented drain current	I _{DN}			750	Α
Continuous DC drain current	I _{DDC}	$T_{\rm vj}$ = 175 °C, $V_{\rm GS}$ = 15 V	T _C = 25 °C	720	А

(table continues...)

XHP™2 module

2 MOSFET



Table 3 (continued) Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
Repetitive peak drain current	/ _{DRM}	verified by design, t _p limited by T _{vjmax}	1500	А
Gate-source voltage, max. transient voltage	V _{GS}	D < 0.01	-10/23	V
Gate-source voltage, max. static voltage	V _{GS}		-7/20	V

Table 4 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	V _{GS(on)}		1518	V
Off-state gate voltage	V _{GS(off)}		-5	V

Table 5 Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Drain-source on-resistance	R _{DS(on)}	I _D = 750 A	$V_{\rm GS} = 15 \text{ V},$ $T_{\rm vj} = 25 ^{\circ}\text{C}$		2.5	3.1	mΩ
			V _{GS} = 15 V, T _{vj} = 125 °C		4.9	6.1	
			V _{GS} = 15 V, T _{vj} = 175 °C		7	8.8	
Gate threshold voltage	V _{GS(th)}	I_D = 675 mA, V_{DS} = V_{GS} , T_{vj} after 1ms pulse at V_{GS} = +		3.45	4.3	5.55	V
Total gate charge	Q _G	$V_{\rm DD}$ = 1800 V, $V_{\rm GS}$ = -5/15 V	1		3.75		μC
Internal gate resistor	R _{Gint}	T _{vj} = 25 °C			1		Ω
Input capacitance	C _{ISS}	$f = 100 \text{ kHz}, V_{DS} = 1800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T _{vj} = 25 °C		152		nF
Output capacitance	C _{OSS}	$f = 100 \text{ kHz}, V_{DS} = 1800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T _{vj} = 25 °C		2.1		nF
Reverse transfer capacitance	C _{rss}	$f = 100 \text{ kHz}, V_{DS} = 1800 \text{ V},$ $V_{GS} = 0 \text{ V}$	T _{vj} = 25 °C		0.086		nF
C _{OSS} stored energy	E _{OSS}	$V_{\rm DS}$ = 1800 V, $V_{\rm GS}$ = -5/15 V	/, T _{vj} = 25 °C		4.4		μJ
Drain-source leakage current	I _{DSS}	$V_{\rm DS}$ = 3300 V, $V_{\rm GS}$ = -5 V	T _{vj} = 25 °C			2000	μA
Gate-source leakage current	I _{GSS}	$V_{\rm DS}$ = 0 V, $T_{\rm vj}$ = 25 °C	V _{GS} = 20 V			10000	nA

(table continues...)

XHP™2 module

2 MOSFET



Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Turn-on delay time	$t_{\sf don}$	$I_{\rm D} = 750 \text{A}, R_{\rm Gon} = 0.5 \Omega,$	T _{vj} = 25 °C		490		ns
(inductive load)		$V_{DD} = 1800 \text{ V},$ $V_{GS} = -5/15 \text{ V}$	T _{vj} = 125 °C		440		
		VGS = -5/13 V	T _{vj} = 175 °C		440		
Rise time (inductive load)	t _r	$I_{\rm D} = 750 \text{ A}, R_{\rm Gon} = 0.5 \Omega,$	T _{vj} = 25 °C		150		ns
		$V_{DD} = 1800 \text{ V},$ $V_{GS} = -5/15 \text{ V}$	T _{vj} = 125 °C		180		
			T _{vj} = 175 °C		180		
Turn-off delay time	$t_{\sf d\ off}$		T _{vj} = 25 °C		280		ns
(inductive load)		$V_{DD} = 1800 \text{ V},$ $V_{GS} = -5/15 \text{ V}$	T _{vj} = 125 °C		310		
		VGS 3/13 V	T _{vj} = 175 °C		320		
Fall time (inductive load)	t _f	$I_{\rm D} = 750 \text{ A}, R_{\rm Goff} = 1.2 \Omega,$	T _{vj} = 25 °C		76		ns
		$V_{DD} = 1800 \text{ V},$ $V_{GS} = -5/15 \text{ V}$	T _{vj} = 125 °C		76		
		VGS - 3/13 V	T _{vj} = 175 °C		76		
Turn-on time (resistive load)	t _{on_R}	$I_{\rm D}$ = 500 A, $V_{\rm DD}$ = 2000 V, $V_{\rm GS}$ = -5/15 V, $R_{\rm Gon}$ = 0.5 Ω	T _{vj} = 25 °C	0.39			μs
Turn-on energy loss per	E _{on}	$I_{\rm D}$ = 750 A, $V_{\rm DD}$ = 1800 V,	T _{vj} = 25 °C		160		mJ
pulse		$L_{\sigma} = 30 \text{ nH}, V_{GS} = -5/15 \text{ V},$ $R_{Gon} = 0.5 \Omega, \text{ di/dt} = 9.1$	T _{vj} = 125 °C		210		
		$kA/\mu s (T_{vj} = 175 °C)$	T _{vj} = 175 °C		260		
Turn-off energy loss per	$E_{ m off}$	$I_{\rm D} = 750 \text{ A}, V_{\rm DD} = 1800 \text{ V},$	T _{vj} = 25 °C		100		mJ
pulse		$L_{\sigma} = 30 \text{ nH}, V_{GS} = -5/15 \text{ V},$ $R_{Goff} = 1.2 \Omega, \text{ dv/dt} = 21$	T _{vj} = 125 °C		100		
		$kV/\mu s (T_{vj} = 175 °C)$	T _{vj} = 175 °C		100		
SC data	I _{SC}	$V_{GS} = -5/15 \text{ V},$ $V_{DD} = 2400 \text{ V},$ $V_{DSmax} = V_{DSS} - L_{sDS} * \text{di/dt},$ $R_G = 0.5 \Omega$	$t_{\rm P} = 3 \mu {\rm s},$ $T_{\rm vj} = 175 ^{\circ}{\rm C}$		6600		A
Thermal resistance, junction to case	R _{thJC}	per MOSFET				33.0	K/kW
Thermal resistance, case to heat sink	R_{thCH}	per MOSFET, λ_{grease} = 1 W	/(m*K)		25.8		K/kW
Temperature under switching conditions	$T_{\rm vjop}$			-40		175	°C

XHP™2 module

3 Body diode (MOSFET)



3 Body diode (MOSFET)

Table 6 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward current	I _{SD}	$T_{\rm vj} = 175 {\rm ^{\circ}C}, V_{\rm GS} = -5 {\rm V}$	T _C = 60 °C	750	А
l ² t - value	I ² t	$V_{\rm DS} = 0 \text{ V}, V_{\rm GS} = -5 \text{ V},$ $t_{\rm P} = 10 \text{ ms}$	T _{vj} = 175 °C	280	kA ² s

Table 7Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Forward voltage	V _{SD}	$I_{SD} = 750 \text{ A}, V_{GS} = -5 \text{ V}$	T _{vj} = 25 °C		4.6	5.8	V
			T _{vj} = 125 °C		3.9	4.9	
			T _{vj} = 175 °C		3.6	4.5	
Reverse recovery energy	E _{rec}	$I_{SD} = 750 \text{ A, di}_{s}/\text{dt} =$	T _{vj} = 25 °C		21		mJ
		9.1 kA/ μ s (T _{vj} = 175 °C), V_{DD} = 1800 V, V_{GS} = -5 V	T _{vj} = 125 °C		33		
		VDD - 1000 V, VGS5 V	T _{vj} = 175 °C		56		

4 NTC-Thermistor

Table 8 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Тур.	Мах.	
Rated resistance	R ₂₅	T _{NTC} = 25 °C		5		kΩ
Deviation of R ₁₀₀	∆R/R	$T_{\rm NTC} = 100 {}^{\circ}{\rm C}$, $R_{100} = 493 \Omega$	-5		5	%
Power dissipation	P ₂₅	T _{NTC} = 25 °C			20	mW
B-value	B _{25/50}	$R_2 = R_{25} \exp[B_{25/50}(1/T_2-1/(298,15 \text{ K}))]$		3375		K
B-value	B _{25/80}	$R_2 = R_{25} \exp[B_{25/80}(1/T_2-1/(298,15 \text{ K}))]$		3411		K
B-value	B _{25/100}	$R_2 = R_{25} \exp[B_{25/100}(1/T_2-1/(298,15 \text{ K}))]$		3433		K

Note: Specification according to the valid application note.

XHP™2 module

5 Characteristics diagrams

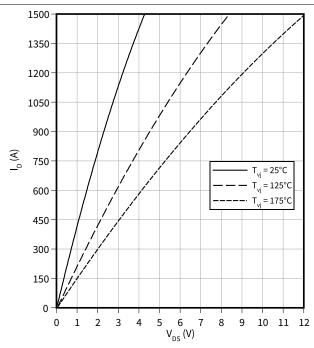


5 Characteristics diagrams

Output characteristic (typical), MOSFET

 $I_D = f(V_{DS})$

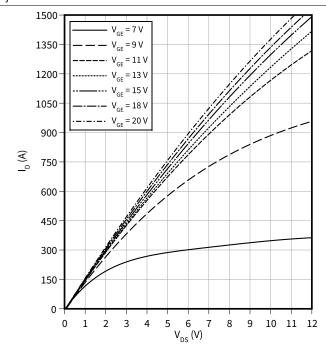
 $V_{GS} = 15 V$



Output characteristic field (typical), MOSFET

 $I_D = f(V_{DS})$

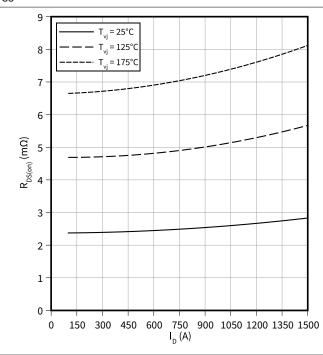
T_{vj} = 175 °C



Drain source on-resistance (typical), MOSFET

 $R_{DS(on)} = f(I_D)$

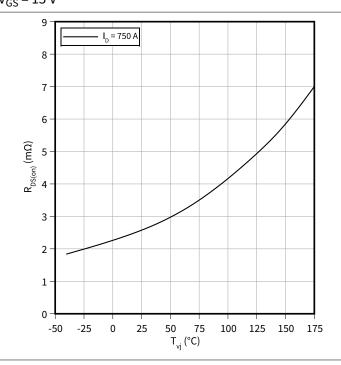
 $V_{GS} = 15 V$



Drain source on-resistance (typical), MOSFET

 $R_{DS(on)} = f(T_{vi})$

V_{GS} = 15 V



XHP™2 module

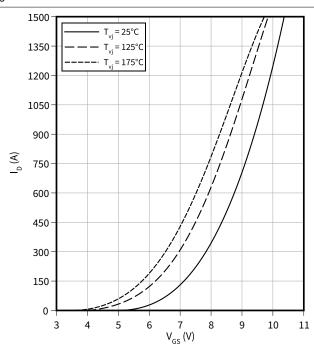
5 Characteristics diagrams



Transfer characteristic (typical), MOSFET

 $I_D = f(V_{GS})$

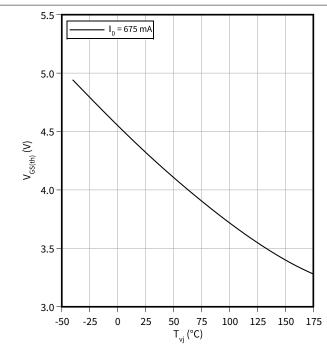
 $V_{DS} = 20 \text{ V}$



Gate-source threshold voltage (typical), MOSFET

 $V_{GS(th)} = f(T_{vj})$

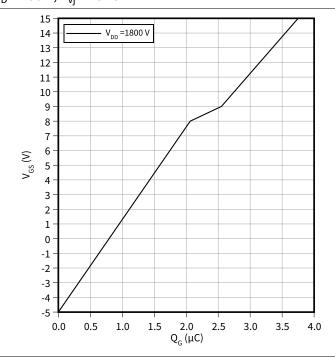
 $V_{GS} = V_{DS}$



Gate charge characteristic (typical), MOSFET

 $V_{GS} = f(Q_G)$

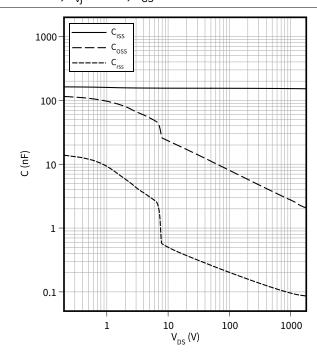
 $I_D = 750 \text{ A}, T_{vj} = 25 \,^{\circ}\text{C}$



Capacity characteristic (typical), MOSFET

 $C = f(V_{DS})$

f = 100 kHz, $T_{vi} = 25 \,^{\circ}\text{C}$, $V_{GS} = 0 \,^{\circ}\text{V}$



XHP™2 module

5 Characteristics diagrams



Switching times (typical), MOSFET

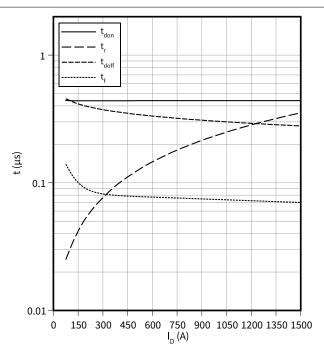
 $t = f(I_D)$

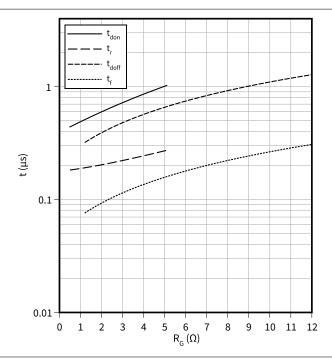
 R_{Goff} = 1.2 Ω , R_{Gon} = 0.5 Ω , V_{DD} = 1800 V, T_{vj} = 175 °C, V_{GS} = -5/15 V



 $t = f(R_G)$

 V_{DD} = 1800 V, I_{D} = 750 A, T_{vj} = 175 °C, V_{GS} = -5/15 V

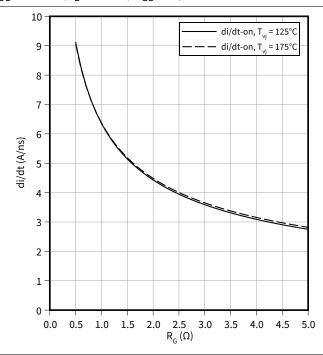




Current slope (typical), MOSFET

 $di/dt = f(R_G)$

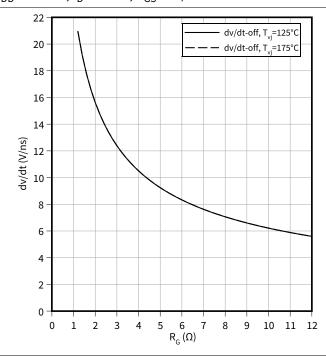
 V_{DD} = 1800 V, I_D = 750 A, V_{GS} = -5/15 V



Voltage slope (typical), MOSFET

 $dv/dt = f(R_G)$

 $V_{DD} = 1800 \text{ V}, I_D = 750 \text{ A}, V_{GS} = -5/15 \text{ V}$



XHP™2 module

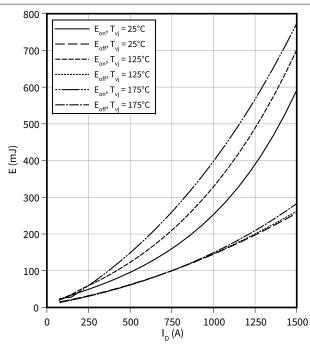
5 Characteristics diagrams



Switching losses (typical), MOSFET

 $E = f(I_D)$

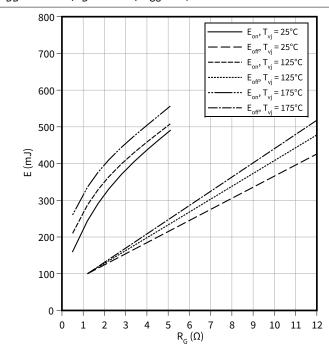
$$R_{Goff} = 1.2 \Omega$$
, $R_{Gon} = 0.5 \Omega$, $V_{DD} = 1800 V$, $V_{GS} = -5/15 V$



Switching losses (typical), MOSFET

 $E = f(R_G)$

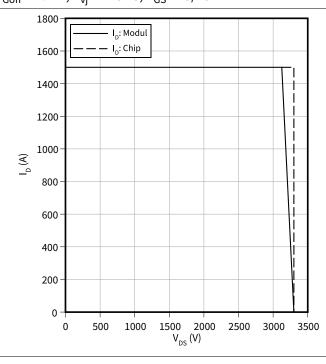
$$V_{DD}$$
 = 1800 V, I_{D} = 750 A, V_{GS} = -5/15 V



Reverse bias safe operating area (RBSOA), MOSFET

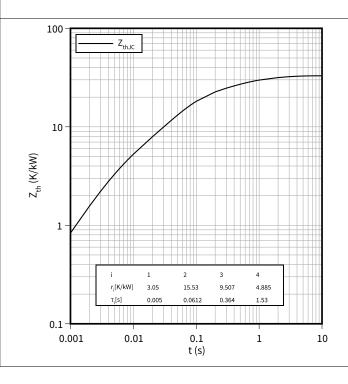
 $I_D = f(V_{DS})$

$$R_{Goff} = 1.2 \Omega$$
, $T_{vj} = 175 \, ^{\circ}$ C, $V_{GS} = -5/15 \, V$

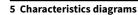


Transient thermal impedance, MOSFET

 $Z_{th} = f(t)$



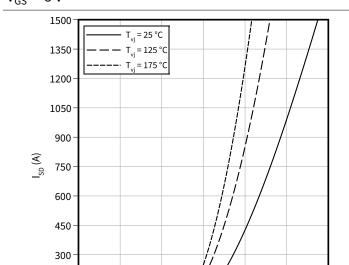
XHP™2 module





Forward characteristic body diode (typical), MOSFET

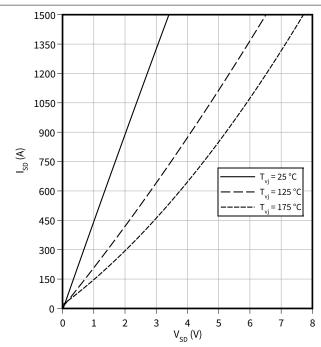
$$I_{SD} = f(V_{SD})$$
$$V_{GS} = -5 V$$



Forward characteristic body diode (typical), MOSFET

$$I_{SD} = f(V_{SD})$$

$$V_{GS} = 15 V$$



Switching losses body diode (typical), MOSFET

2

3

 $V_{SD}(V)$

4

5

6

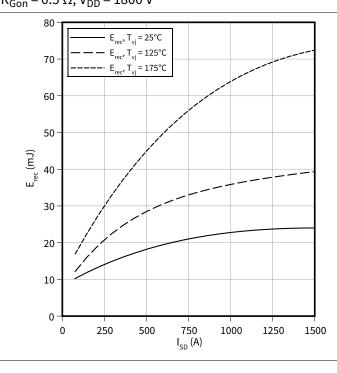
1

$$E_{rec} = f(I_{SD})$$

$$R_{Gon} = 0.5 \Omega, V_{DD} = 1800 V$$

150

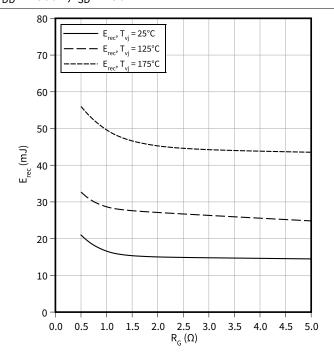
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Switching losses body diode (typical), MOSFET

$$E_{rec} = f(R_G)$$

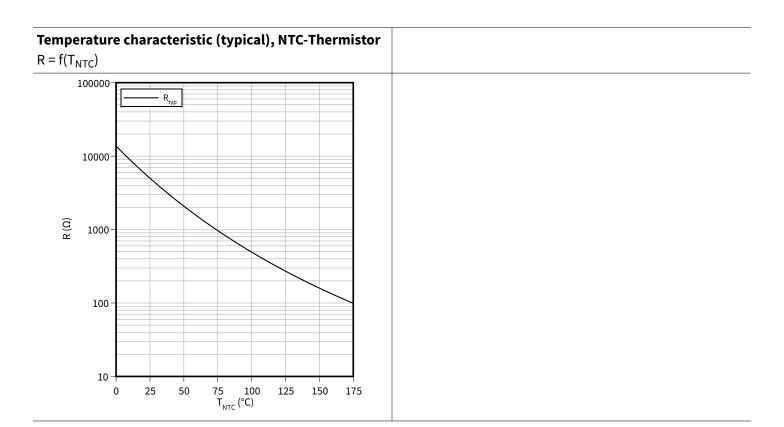
$$V_{DD}$$
 = 1800 V, I_{SD} = 750 A



XHP™2 module



5 Characteristics diagrams



6 Circuit diagram



6 Circuit diagram

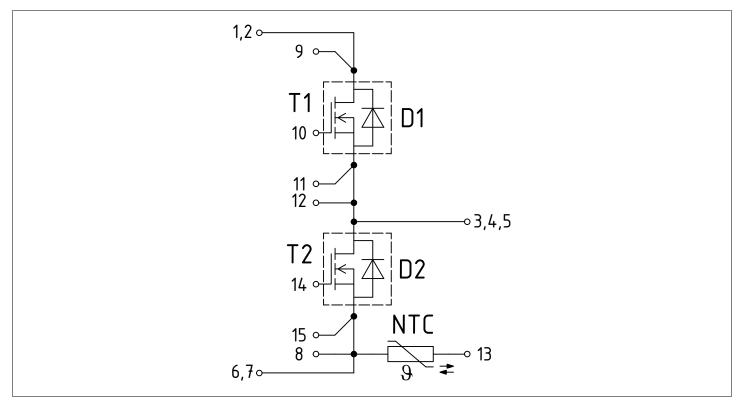


Figure 1

7 Package outlines



7 Package outlines

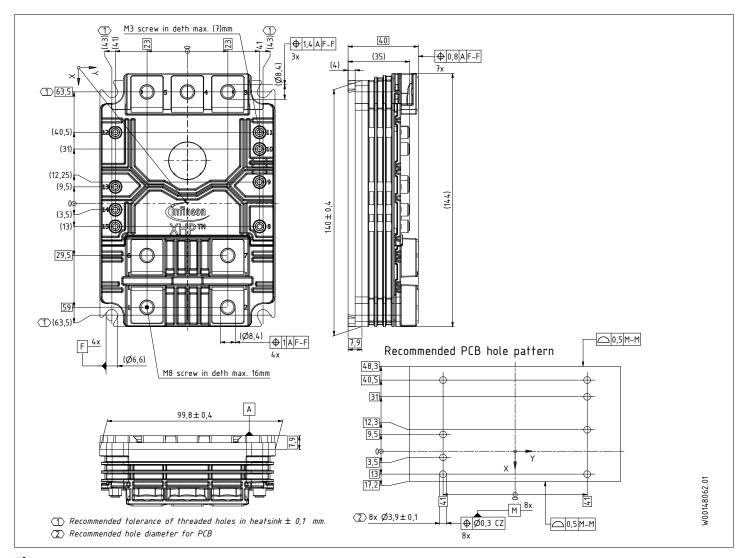


Figure 2

XHP™2 module

8 Module label code



8 Module label code

Cadafarmat	Data Matrix		Daysond - C	`ada120
Code format	Data Matrix		Barcode C	Jode128
Encoding	ASCII text		Code Set /	A
Symbol size	16x16		23 digits	
Standard	IEC24720 and IEC16022		IEC8859-1	
Code content	Content	Digit		Example
	Module serial number	1-5		71549
	Module material number	6 - 11		142846
	Production order number	12 - 19		55054991
	Date code (production year)	20 – 21		15
	Date code (production week)	22 – 23		30
Example	BOOK FOR Y			

Figure 3

XHP™2 module

Revision history



Revision history

Document revision	Date of release	Description of changes
V1.0	2020-04-23	Target datasheet
n/a	2020-09-01	Datasheet migrated to a new system with a new layout and new revision number schema: target or preliminary datasheet = 0.xy; final datasheet = 1.xy
0.20	2023-11-21	Preliminary datasheet
1.00	2024-04-16	Final datasheet

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